Notice of References Cited Application/Control No. 10/677,522 Examiner Seung H. Lee Applicant(s)/Patent Under Reexamination BARKAN ET AL. Page 1 of 1

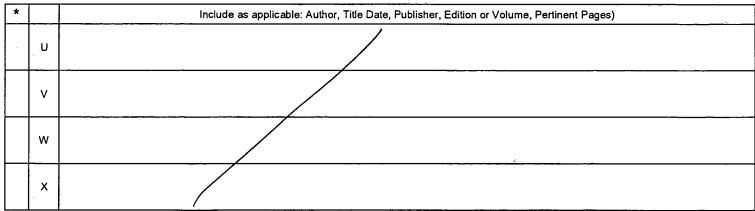
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,786,413	09-2004	Gurevich et al.	235/462.4
	В	US-6,045,046	04-2000	Detwiler, Paul O.	235/114
	С	US-6,543,694	04-2003	Detwiler, Paul O.	235/462.4
	D	US-		/	
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS



*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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